Structure-Dependent Microwave Dielectric Properties and Middle-Temperature Sintering of Forsterite (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ Ceramics

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The crystal structure, microstructure, and microwave dielectric properties of forsterite-based (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ($x = 0.02$–$0.20$) ceramics were systematically investigated. All samples present a single forsterite phase of an orthorhombic structure with a space group Pbnm except for a little MgSiO$_3$ secondary phase as $x > 0.08$. Lattice parameters in all axes decrease linearly with increasing Ni content due to the smaller ionic radius of Ni$^{2+}$ compared to Mg$^{2+}$. The substitution of an appropriate amount of Ni$^{2+}$ could greatly improve the sintering behavior and produce a uniform and closely packed microstructure of the Mg$_2$SiO$_4$ ceramics such that a superior $Q \times f$ value (152 300 GHz) can be achieved as $x = 0.05$. The $\tau_f$ value was found to increase with increasing A-site ionic bond valences. In addition, various additives were used as sintering aids to lower the sintering temperature from 1500°C to the middle sintering temperature range. Excellent microwave dielectric properties of $\varepsilon_r = 6.9$, $Q \times f = 99800$ GHz and $\tau_f = 50$ ppm°C can be obtained for 12 wt% Li$_2$CO$_3$-V$_2$O$_5$-doped (Mg$_{0.95}$Ni$_{0.05}$)$_2$SiO$_4$ ceramics sintered at 1150°C for 4 h.

I. Introduction

Many superior materials with a complex perovskite or a corundum structure such as Ba(Zn$_{1/3}$Ta$_{2/3}$)O$_3$, Al$_2$O$_3$, Mg$_2$Nb$_2$O$_6$ have been extensively investigated as candidates for high-frequency applications owing to their low dielectric constant ($\varepsilon_r$) together with high quality factor ($Q$) values. And search for new low-loss and low-cost dielectric ceramics is always a primary issue in the last few years. In return for many efforts, numerous silicates and titanates including Mg$_2$SiO$_4$, Zn$_2$SiO$_4$, MgTiO$_3$, and Mg$_2$TiO$_3$ have been reported to possess a considerably high $Q$ showing a great potential for millimeter-wave applications. Thus, much scientific and commercial attention have been attracted to improve the sinterability and microwave dielectric properties of these compounds by various A- or B-site ionic substitution, for instance, (Mg$_{1-x}$Al$_x$)$_2$SiO$_4$ (M=Ca, Mn), Mg$_2$(Si$_{1-x}$Ti$_x$)O$_4$, Mg$_2$(Si$_{1-x}$Co$_x$)$_2$TiO$_4$, Mg$_2$(Mg$_{1-x}$Mn$_x$)$_2$TiO$_4$, and Mg$_2$(Ti$_{1-x}$Sn)$_2$O$_4$. Among these promising materials, forsterite Mg$_2$SiO$_4$ ceramics with high performance have been particularly considered because of its low-cost, easily processable, and lightweight characteristics. Its low $\varepsilon_r$ of 6.8 and extremely high $Q \times f$ value of 240 000 GHz were first reported by Tsunooka et al. However, the metastable enstatite or protoenstatite secondary phases are difficult to be completely eliminated from the Mg$_2$SiO$_4$ sample via a mixed-oxide route, which not only result in poor sinterability but also greatly deteriorate the $Q$ value. Some efforts have been made to synthesize pure-phase Mg$_2$SiO$_4$ by sol–gel or other wet chemical processes. Nevertheless, Song et al. still successfully prepared the single-phase Mg$_2$SiO$_4$ via the conventional solid-state route by adjusting the Mg/Si ratio. However, it could be noted that the $Q \times f$ values of Mg$_2$SiO$_4$ ceramics reported in most prior work are significantly lower than those reported in a previous paper. In addition, some miscellaneous information on $Q \times f$ values for the Mg$_2$SiO$_4$ ceramics reported by the same group might reflect the strong processing sensitivity of the forsterite ceramics. Recently, it was hypothesized that the temperature coefficient of resonant frequency ($\tau_f$) of the Mg$_2$SiO$_4$ ceramic is closely related to the ionic radii of Al and A2-site cations in the olivine structure, and ions with larger ionic radii and polarizability such as Ca$^{2+}$ and Mn$^{2+}$ tend to bring its $\tau_f$ toward minus.

Compared to Mg$^{2+}$, Ni$^{2+}$ can be expected to tailor the $\tau_f$ value of the forsterite ceramic owing to its relatively small ionic radius. Particularly, the relation between the microwave dielectric properties and the structure for the Ni$^{2+}$-doped Mg$_2$SiO$_4$ system has not yet been explored from the crystallographic point of view. The experimentally measured microwave dielectric properties were investigated based upon the phase composition, densification, structural characteristics, and microstructures of the ceramics. Moreover, the sintering temperature of (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ is considerably high in the currently reported microwave dielectric ceramics. Thus, 12 wt % ZnO-V$_2$O$_5$, Li$_2$CO$_3$-V$_2$O$_5$, Li$_2$CO$_3$-Bi$_2$O$_3$, and Li$_2$CO$_3$-Bi$_2$O$_3$ were used as sintering aids, respectively, to reduce its sintering temperature down to a middle-temperature range.

II. Experimental Procedure

The (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ($x = 0.02$–$0.20$) ceramics were prepared by a solid-state reaction method using starting materials of high-purity (≥99%) oxide powders: 4MgCO$_3$-Mg(OH)$_2$-5H$_2$O, CaH$_2$O$_3$-Ni-4H$_2$O, and SiO$_2$ (Sinopharm Chemical Reagent Co. Ltd, Shanghai, China). The powders with the corresponding stoichiometric compositions were ball milled in a nylon jar with zirconia balls on a planetary milling machine (QM-3SP2; NanDa Instrument Plant, Nanjing, China) at 360 rpm for 8 h using distilled water as the media. The slurries were dried at 100°C for 24 h, calcined in air at 1200°C for 3 h, and remilled for 8 h afterward. Subsequently, the obtained mixtures were dried, granulated with 5 wt% PVA in an agate mortar, and then pressed into cylinders of 10 mm in diameter and 5–6 mm in height under a uniaxial pressure of 100 MPa in a stainless-steel die. These samples were first heated at 550°C for 4 h to burn out the organic binder, and then sintered in air at temperatures from 1300°C to 1550°C for 4 h. Moreover, 2ZnO-V$_2$O$_5$, Li$_2$CO$_3$-V$_2$O$_5$, Li$_2$CO$_3$-Bi$_2$O$_3$, and Li$_2$CO$_3$-Bi$_2$O$_3$ prepared by mixing the corresponding stoichiometric oxides or carbonates in an agate mortar for 3 h were used as the sintering aids to lower the sintering temperatures of the studied materials.
The crystalline structures of the sintered samples were determined by an X-ray diffractometer (XRD; D/Max2500V, Rigaku, Tokyo, Japan) using Cu Kα radiation (λ = 1.5406 Å) with a step size of 0.01°. The structural parameters were obtained from Rietveld refinement of the XRD data using the FullProf software. The bulk densities of the sintered samples were measured by the Archimedes method. For convenience, the microstructural observation on the natural surface of the sintered samples was performed using a scanning electron microscope (SEM; JEOL JSM-6490LV, Tokyo, Japan) equipped with an energy dispersive spectrometer (EDS). Here, the natural surface refers to the outside surface of the postsintered pellets, instead of the polished and thermally etched surface. A network analyzer (N5230C; Agilent, Palo Alto, CA) and a temperature chamber (GDW-100; Saiweisi, Changzhou, China) were used to measure the dielectric properties of the well-polished ceramic samples with an aspect ratio of 1.8. The dielectric constants were measured using the parallel conducting plates and the coaxial electric probes as suggested by Courtney at the TEO11 mode of resonance, which can be least perturbed by the surrounding field variations. For the measurement of the Q value, the sample was placed on the low-loss quartz support of 8 mm diameter and 4 mm height in the center of the cylindrical silver-clad shielded cavity (Resonant cavity; QWED, Warsaw, Poland) with an inner diameter of 32 mm and a height of 18 mm. The loaded quality factor QL in transmission mode (S21 parameter) was determined from the full-width of the resonance peak at 3 dB level. The dielectric loss (tanδ) was calculated by using the software provided by the TEO11 shield cavity supplier, through which the Q values can be obtained in accordance with the equation $Q = 1/tanδ$. The τf value of the samples was measured by noting the change in the resonant frequency over a temperature interval from 25°C to 80°C, and it can be calculated by the following equation:

$$\tau_f = \frac{f_2 - f_1}{f_1(T_2 - T_1)}$$

where $f_1$ and $f_2$ represent the resonant frequencies at $T_1$ and $T_2$, respectively.

### III. Results and Discussion

Figure 1(a) depicts the XRD patterns of (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ($x = 0.02-0.20$) ceramics sintered at 1500°C for 4 h. All the main diffraction peaks can be well indexed in terms of the standard patterns of orthorhombic-structured Mg$_2$SiO$_4$ (JCPDS #34-0189), indicating that the forsteritic-olivine solid solution was formed as a single phase. A very little protoenstatite MgSiO$_3$ secondary phase appeared along with the main phase Mg$_2$SiO$_4$ in compositions with $x > 0.08$. The possible reason might be ascribed to the fact that the amount of Mg$_2$SiO$_4$ is insufficient so that it could not react with Mg$_2$SiO$_3$ secondary phase to form Mg$_2$SiO$_4$. This result is consistent with a previous report where protoenstatite was easily formed as a by-product when the solid reaction route was used to synthesize the forsterite, because of slow kinetics of the solid-state diffusion. Such impurity phase probably results in poor sinterability of the samples and then extremely degrades the sample’s Q value. Furthermore, it can be also found that the intensity of all diffraction peaks have almost no changes except for the peak at ~17° as x value varied. This result is probably ascribed to the occurrence of the preferred grain orientation induced by the Ni substitution.

The detailed structural characteristics of (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ceramics were analyzed using a Rietveld refinement method. The lattice parameters, Wyckoff site, atomic fractional coordinates and occupancy were initiated by using the Mg$_2$SiO$_4$ structural data from the Findit software. In crystallography, the Wyckoff site is one of a set of points for which the site symmetry groups are conjugated subgroups of space group. It was well-known that the olivine is an orthosilicate with a general formula of A1A2SiO$_4$, where both the A1 and A2 sites are 6-coordinated. And the [MgO$_6$] octahedra in forsterite share edges to create chains along the c axis, which have two alternating and distinct types, as shown in Fig. 2(a). The previous studies of X-ray structure refinements, as well as crystal field spectra found that the A1 site is relatively small and flattened along its threefold axis, yet the A2 site is slightly large and is much more distorted. This means the cations with relatively small radii and high octahedral site preference energies, for example, Ni$^{2+}$ and Co$^{2+}$ have a preference for the A1 site. Thus, the occupancy of Ni$^{2+}$ should be allotted for the A1 site of forsterite in the refinement. Simultaneously, the nominal concentration of Ni$^{2+}$ was used to obtain its occupancy. This parameter was not refined because Ni$^{2+}$ could totally dissolve into the Mg$_2$SiO$_4$ lattice as confirmed by a previous study. Moreover, the modes used for the calculation of the peak shape and background were Pseudo-Voigt and 6-coefficients polynomial functions, respectively. As the XRD results confirm that samples with $x > 0.08$ contain some impurity phases, a mixture model has been employed for refinement of these samples. The weight fractions of the MgSiO$_3$ impurity phase based on the refined scale factor were found to be 2.53%, 2.76%, and 2.92% corresponding to the $x = 0.10$, 0.15, and 0.20 samples, respectively. The results confirm that the Mg$_2$SiO$_4$ phase as...
Table I. Refined Lattice Parameters (a, b, and c) and Unit Cell Volume (V_{unit}) of (Mg_{1-x}Ni_x)SiO_4 (x = 0.02–0.20) Ceramics Sintered at 1500°C for 4 h

<table>
<thead>
<tr>
<th>Ni Content (x)</th>
<th>a (Å)</th>
<th>b (Å)</th>
<th>c (Å)</th>
<th>V_{unit} (Å³)</th>
<th>R_{wp} (%)</th>
<th>R_{fd} (%)</th>
<th>χ^2</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.02</td>
<td>4.7548(6)</td>
<td>10.2043(4)</td>
<td>5.9778(5)</td>
<td>289.68(1)</td>
<td>9.79</td>
<td>7.06</td>
<td>1.547</td>
</tr>
<tr>
<td>0.05</td>
<td>4.7532(4)</td>
<td>10.2041(1)</td>
<td>5.9759(8)</td>
<td>289.536(7)</td>
<td>8.45</td>
<td>5.61</td>
<td>1.426</td>
</tr>
<tr>
<td>0.08</td>
<td>4.7527(3)</td>
<td>10.2036(2)</td>
<td>5.9736(7)</td>
<td>289.478(6)</td>
<td>11.4</td>
<td>9.42</td>
<td>1.656</td>
</tr>
<tr>
<td>0.10</td>
<td>4.7519(2)</td>
<td>10.2032(3)</td>
<td>5.9723(8)</td>
<td>289.448(6)</td>
<td>12.3</td>
<td>10.6</td>
<td>1.741</td>
</tr>
<tr>
<td>0.15</td>
<td>4.7510(2)</td>
<td>10.2028(2)</td>
<td>5.9698(4)</td>
<td>289.365(3)</td>
<td>9.13</td>
<td>6.58</td>
<td>1.469</td>
</tr>
<tr>
<td>0.20</td>
<td>4.7503(1)</td>
<td>10.2025(4)</td>
<td>5.9682(3)</td>
<td>289.251(2)</td>
<td>8.83</td>
<td>6.14</td>
<td>1.473</td>
</tr>
</tbody>
</table>
weight fractions of Mg$_2$SiO$_4$ and MgSiO$_3$, respectively. For all samples, with increasing the sintering temperature, the relative densities gradually increase up to 1500$^\circ$C and then reach a maximum value, which is due to the grain growth and the decrease in pores (whose $\varepsilon_r$ near to 1), as shown in Figs. 3(b) and (g). The relative densities decline afterward, suggesting that 1500$^\circ$C would be the optimized sintering temperature. Of note is that the sample with $x = 0.05$ has the highest relative density of 97.5% compared to other compositions, which can be attributed to the reduction in porosity, the increase in average grain size and its relatively uniform microstructure [Fig. 3(b)].

Generally, the $\varepsilon_r$ is dependent on the ionic polarizabilities of the composition, relative density and secondary phase. The variation in $\varepsilon_r$ exhibits almost a similar behavior to that of relative density with the sintering temperature. To evaluate the relative error in the measurement of $\varepsilon_r$, we have calculated the observed polarizability ($\alpha_{obs}$) and the theoretical $\varepsilon_r$ ($\varepsilon_{theo}$) by the Clausius–Mosotti relation,$^{23}$ as defined in Eqs. (4) and (5):

![Fig. 3. SEM micrographs of (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ceramics sintered at 1500$^\circ$C for 4 h: (a) $x = 0.02$, (b) $x = 0.05$, (c) $x = 0.08$, (d) $x = 0.10$, (e) $x = 0.15$, (f) $x = 0.20$, and (Mg$_{0.95}$Ni$_{0.05}$)$_2$SiO$_4$ ceramics sintered at different temperatures for 4 h: (g) 1450$^\circ$C, (h) 1550$^\circ$C.](image)
where $b$ is defined as $4\pi/3$, $\varepsilon_{\text{obs}}$ is the dielectric constant measured, $V_{\text{m}}$ is the molecular volume, and $\varepsilon_{\text{theo}}$ is the sum of theoretical ionic polarizability ($\text{Mg}^{2+}$: 1.32 Å$^3$, $\text{Ni}^{2+}$: 1.23 Å$^3$, $\text{Si}^{4+}$: 0.87 Å$^3$, $\text{O}^{2-}$: 2.01 Å$^3$). All data involved are listed in Table II. It can be seen that all the values of $\varepsilon_{\text{theo}}$, $\varepsilon_{\text{obs}}$, and $\varepsilon_{\text{obs}}/\varepsilon_{\text{theo}}$ have an agreeable trend of decreasing with the Ni content increasing. The $\varepsilon_{\text{obs}}$ value decreases from 6.82 to 6.68 with increasing $x$ due to the smaller ionic polarizability of $\text{Ni}^{2+}$ (1.23 Å$^3$), as well as the smaller $\varepsilon_i$ of $\text{MgSiO}_3$ (6.45) than that of $\text{Mg}_2\text{SiO}_4$ (6.8). In addition, a certain deviation between the theoretical and the experimental results exists, and is correlated with the relative density.

Figure 5 displays the $Q \times f$ values of (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ceramics as a function of the sintering temperature. The microwave dielectric loss is not only related to the intrinsic loss such as the lattice vibrational modes, but also is closely associated with extrinsic losses such as porosity, grain boundaries, microcracks, secondary phases, and impurities. The variation of $Q \times f$ shows a similar trend to that of the relative density, which reflects that the dielectric loss was mainly dominated by the densification of the ceramics. It is noteworthy that a marked enhancement of the $Q \times f$ value (96 180–152 300 GHz) appears in (Mg$_{0.95}$Ni$_{0.05}$)$_2$SiO$_4$ samples with increasing the sintering temperature from 1450°C to 1500°C. This might be by virtue of the grain growth and the reduction in grain boundaries [Figs. 3(b) and (g)], which usually act as sinks for the accumulation of the impurities during the sintering process and thus have a deleterious influence on the extrinsic loss. Then the $Q \times f$ value decreases with further increase of the sintering temperature because of the nonuniform and abnormal grain growth, as shown in Fig. 3(h). In addition, for samples with $x > 0.08$, the overall $Q \times f$ values were lower than those of the samples with less $x$, probably due in large part to the appearance of MgSiO$_3$ phase, whose $Q \times f$ value was reported to be about 60 000 GHz. Thus, a maximum $Q \times f$ value of 152 300 GHz could be achieved for the samples of (Mg$_{0.95}$Ni$_{0.05}$)$_2$SiO$_4$ sintered at 1500°C for 4 h. This result indicates that a superior $Q \times f$ value can be obtained in $\text{Mg}_2\text{SiO}_4$ ceramics by an appropriate substitution, as already shown in other solid solutions.

Another important dielectric property for microwave applications is $\tau_p$, which determines the thermal stability of materials and devices. The $\tau_p$ of materials basically results from the $\tau_p$ related to the chemical nature of constituent ions, the distance between cations and anions and the structural characteristics originating from the bonding type. These structural characteristics could be evaluated by the bond valence of ions. The bond valence $V_{ij}$ of atom $i$, was defined as the sum of all of the valences from a given atom $i$, and could be calculated by Eqs. (6) and (7).28

\[
\varepsilon_{\text{obs}} = \frac{V_{\text{m}}(\varepsilon_{\text{obs}} - 1)}{b(\varepsilon_{\text{obs}} + 2)} \tag{4}
\]

\[
\varepsilon_{\text{theo}} = \frac{3}{1 - b\varepsilon_{\text{theo}}/V_{\text{m}}} - 2 \tag{5}
\]

---

Table II. Comparison of Theoretical and Observed Polarizabilities, as well as Dielectric Constants of (Mg$_{1-x}$Ni$_x$)$_2$SiO$_4$ ($x = 0.02$–$0.20$) Ceramics Sintered at 1500°C for 4 h

<table>
<thead>
<tr>
<th>Ni Content ($x$)</th>
<th>Theoretical</th>
<th>Observed</th>
<th>$\Delta%$</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>$\varepsilon_{\text{theo}}$</td>
<td>$\varepsilon_{\text{obs}}$</td>
<td>$F_{\text{unit}}$ (Å)</td>
</tr>
<tr>
<td>0.02</td>
<td>11.5464</td>
<td>6.82</td>
<td>289.6774</td>
</tr>
<tr>
<td>0.05</td>
<td>11.5410</td>
<td>6.80</td>
<td>289.5360</td>
</tr>
<tr>
<td>0.08</td>
<td>11.5356</td>
<td>7.77</td>
<td>289.4779</td>
</tr>
<tr>
<td>0.10</td>
<td>11.5320</td>
<td>6.74</td>
<td>289.4482</td>
</tr>
<tr>
<td>0.15</td>
<td>11.5230</td>
<td>6.70</td>
<td>289.3651</td>
</tr>
<tr>
<td>0.20</td>
<td>11.5140</td>
<td>6.68</td>
<td>289.2510</td>
</tr>
</tbody>
</table>
where \( R_{ij} \) is the bond valence parameter, \( d_{ij} \) is the length of a bond between atom i and j, and \( b' \) is commonly taken to be a universal constant equal to 0.37 Å. It has been reported that the \( \tau_R \) of a complex perovskite would decrease as the bond valence of the A-site decreased, owing to the tilting of the oxygen octahedra induced by the smaller ionic radius of the A site. The same phenomenon has also been shown in tetragonal scheelite structures and monoclinic-structured Zn3Nb2O8 ceramics.26,28 In this study, the bond lengths were calculated using the Bond_Str program (FullProf suite 2.05) and the results are listed in Table III, together with the calculated using the Bond_Str program (FullProf suite 2.05)

\[
R_{ij} = \exp\left(\frac{-d_{ij} - d_{ij0}}{b'}\right) 
\]

(6)

\[
V_{ij} = \sum v_{ij} 
\]

(7)

In addition to the microwave dielectric properties, the low-temperature sinterability of materials should be an important factor in electronic industry for microwave applications. To the best of our knowledge, only a few studies have been conducted to lower the sintering temperature of forsterite-based ceramics. Sebastian et al. have reported that addition of 15 wt% lithium borosilicate or lithium magnesium zinc borosilicate could lower the sintering temperature of forsterite ceramics from 1500°C to about 950°C, resulting in the Q × f values of approximately 30 000 GHz.31,32 Thus, in this study, we attempt to use four low-melting additives including 2ZnO-V2O5, Li2CO3-B2O3, Li2CO3-Bi2O3, and Li2CO3-Bi2O3 to lower the sintering temperature of (Mg0.95Ni0.05)2SiO4 ceramics. It was found that controlling the additive dosage at 12 wt% could not only effectively lower the sintering temperature, but also maintain excellent mechanical properties of the sintered samples at different temperatures. With increasing sintering temperature, the apparent density of the samples increases to a maximum value and decreases thereafter. The samples with 12 wt% Li2CO3-V2O5 could achieve the highest density of approximately 3.4 g/cm³ at about 1150°C. It can be noted that the variation in the apparent density is remarkable for all four samples, indicating that the sintering window of the (Mg0.95Ni0.05)2SiO4 ceramics with additives is rather narrow. Moreover, the addition of 12 wt% 2ZnO-V2O5, Li2CO3-V2O5, or Li2CO3-Bi2O3 could effectively lower the sintering temperature to 1150°C, however, the addition of 12 wt% Li2CO3-Bi2O3 could only reduce it to 1250°C. The SEM micrographs of the natural surface of these samples sintered at their optimized temperatures are also offered in Figs. 7(b)–(e). It can be observed that the sample’s surface morphology changed obviously from planar grains [Fig. 3(b)] to virgulate and massive grains [Figs. 7(b)–(e)]. Furthermore, a bimodal grain size distribution appears in all samples, and the EDS analysis was carried out to identify the compositions of different grains, as shown in Figs. 7(f) and (g). The results demonstrated that both small and large grains [marked S and L in Figs. 7(b)–(e), respectively] consist of Si, Mg, Ni, and O elements in an approximate molar ratio of Si:

![Figure 6](image)

Table III. The Effective Bond Valence Parameter, Length of Bonds, and A-site Bond Valence of (Mg0.95Ni0.05)2SiO4 ceramics sintered at 1500°C for 4 h

<table>
<thead>
<tr>
<th>( x )</th>
<th>( R_{A-O} )</th>
<th>( 2d(A1−) )</th>
<th>( d(A2−) )</th>
<th>( V_{A-O} )</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.02</td>
<td>1.6922</td>
<td>2.1237</td>
<td>2.2258</td>
<td>3.5598</td>
</tr>
<tr>
<td>0.05</td>
<td>1.6911</td>
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<td>2.2255</td>
<td>3.5809</td>
</tr>
<tr>
<td>0.08</td>
<td>1.6899</td>
<td>2.1195</td>
<td>2.2253</td>
<td>3.5983</td>
</tr>
<tr>
<td>0.10</td>
<td>1.6891</td>
<td>2.1174</td>
<td>2.2259</td>
<td>3.6242</td>
</tr>
<tr>
<td>0.15</td>
<td>1.6872</td>
<td>2.1122</td>
<td>2.2473</td>
<td>3.6625</td>
</tr>
<tr>
<td>0.20</td>
<td>1.6852</td>
<td>2.1085</td>
<td>2.2503</td>
<td>3.6893</td>
</tr>
</tbody>
</table>
Mg:Ni:O = 10:19:1:40, suggesting that both small and large grains belong to the \((\text{Mg}_{0.95}\text{Ni}_{0.05})_{2}\text{SiO}_4\) phase.

The microwave dielectric properties of \((\text{Mg}_{0.95}\text{Ni}_{0.05})_{2}\text{SiO}_4\) ceramics doped with 12 wt% additives as a function of the sintering temperature are depicted in Fig. 8. The variation of both \(\varepsilon_r\) and \(Q \times f\) values was consistent with the change of the sample density. The \(\varepsilon_r\) value of the samples with 12 wt% Li\(_2\)CO\(_3\)-V\(_2\)O\(_5\), Li\(_2\)CO\(_3\)-B\(_2\)O\(_3\), and Li\(_2\)CO\(_3\)-Bi\(_2\)O\(_3\) is approximately in the range 6.4–6.86, which is roughly similar to that of the matrix phase \((\varepsilon_r = 6.8)\). The decreased \(\varepsilon_r\) might be related to the decreased densities. For the samples with 12 wt% 2ZnO-V\(_2\)O\(_5\), both increased \(\varepsilon_r\) (7.2–7.5) and decreased \(\tau_f\) (−75 ppm/°C) values should be mainly ascribed to the presence of some Zn\(_2\)V\(_2\)O\(_5\), Mg\(_3\)(VO\(_4\))\(_2\) and Zn\(_2\)Si\(_4\) phases, because both Mg\(_3\)(VO\(_4\))\(_2\) (\(\varepsilon_r\sim 9.3\), \(\tau_f\sim 89.5\) ppm/°C)\(^3\) and Zn\(_2\)Si\(_4\) (\(\varepsilon_r\sim 6.6\), \(\tau_f\sim 61\) ppm/°C)\(^2\) show larger \(\varepsilon_r\) and smaller \(\tau_f\) values. According to our previous work,\(^2\) the Zn\(_3\)V\(_2\)O\(_7\) can be formed by the decomposition of the Zn\(_3\)(VO\(_4\))\(_2\) phase as sintering temperature exceeds 815°C and it has similar \(\varepsilon_r\) and \(\tau_f\) values to those of Zn\(_3\)(VO\(_4\))\(_2\) (\(\varepsilon_r\sim 10\), \(\tau_f\sim 120\) ppm/°C). Despite the content of these secondary phases would be very low, the \(\tau_f\) value of the ceramics was obviously reduced.

In addition, all samples exhibited considerably low \(Q \times f\) values (66 700–99 800 GHz) compared to that of the matrix phase (152 300 GHz), owing mostly likely to both the presence of various secondary phases and relatively low densities. Nevertheless, the \((\text{Mg}_{0.95}\text{Ni}_{0.05})_{2}\text{SiO}_4\) ceramics with 12 wt% Li\(_2\)CO\(_3\)-V\(_2\)O\(_5\) sintered at 1150°C for 4 h attain a low \(\varepsilon_r\) value of 6.9, an excellent \(Q \times f\) value of 99 800 GHz and a \(\tau_f\) value of −50 ppm/°C, probably being a potential candidate for microwave dielectric substrate applications.

IV. Conclusions

The microwave dielectric properties of forsterite-based \((\text{Mg}_{1-x}\text{Ni}_x)_{2}\text{SiO}_4\) \((x = 0.02–0.20)\) ceramics were investigated in terms of their structural characteristics, microstructure, as well as the sintering behavior. The results demonstrate that the Ni substitution not only significantly boosts the densification behavior but also improves the microwave dielectric properties of the ceramics. The \(\tau_f\) value of the samples was found to increase with increasing the A-site bond valence. A low \(\varepsilon_r\) of 6.8 and a high \(Q \times f\) value of 152 300 GHz can be achieved in the \((\text{Mg}_{0.95}\text{Ni}_{0.05})_{2}\text{SiO}_4\) sample. In addition,
Fig. 8. Microwave dielectric properties of (Mg$_{0.95}$Ni$_{0.05}$)$_2$SiO$_4$ ceramics with 12 wt% (a) 2ZnO-V$_2$O$_5$, (b) Li$_2$CO$_3$-V$_2$O$_5$, (c) Li$_2$CO$_3$-Bi$_2$O$_3$, and (d) Li$_2$CO$_3$-Bi$_2$O$_3$ additives sintered at different temperatures for 4 h.

four different additives were used as sintering aids to lower its sintering temperature from 1500°C down to the middle sintering temperature range. The (Mg$_{0.95}$Ni$_{0.05}$)$_2$SiO$_4$ ceramics with 12 wt% Li$_2$CO$_3$-V$_2$O$_5$ sintered at 1150°C for 4 h achieved excellent microwave dielectric properties of $\varepsilon_r$~6.9, $Q \times f$~99 800 GHz and $\tau_f$~50 ppm/°C, indicating possible materials for millimeter-wave device applications.

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References


